## Annealing duration influence on dip-coated CZTS thin films properties obtained by sol-gel method

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Abstract: The effect of annealing duration on structural and optical properties of dip-coated crystallineCZTS thin films was studied. The obtained samples were investigated by several techniques suchas XRD, Raman spectroscopy, SEM, UV-vis spectroscopy and Photoluminescence. Being con-firmed by Raman spectroscopy, XRD analysis reveals the formation of kesterite tetragonal phasewith preferential orientation along (112) direction. The grain size tends to increase as the an- nealing duration increases, a result confirmed by SEM. The last shows smooth, uniform, homo-geneous and densely packed grains. Optical measurement analysis reveals that layers have re- latively high absorption coefficient in the visible spectrum with a band gap reduction of 1.62?1.50 eV which is quite close to the optimum value for a solar cell. The photoluminescence distinguishes broad bands that have maximums of intensity limited between 1.50 and 1.62 eV, corresponding to the optical band gap of the CZTS.Kesterite, Sol-gel, Thin-film, Dip-coating, CZTS, Photoluminescence

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